FORM PTO-1449 (Modified)

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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

ATTY. DOCKET NO. JEV/KAR:1016.2018

SERIAL NO.

APPLICANT Ron A. Peters et al.

FILING DATE July 8, 2003 GROUP

REFERENCE DESIGNATION
U.S. PATENT DOCUMENTS

		·	U.S. PAT	ENT DOCUMENTS		ė.				<u> </u>
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CL	ASS	su	BCLASS	FILING APPRO	DATE IF
DW	AA	3,185,927	5/25/1965	Margulis et al.		. /	1	\		
	AB	3,333,274	7/25/1967	Forcier		1				
	AC	3,405,361	10/8/1968	Kattner et al.	-					
	AD	3,710,251	1/9/1973	Hagge et al.	1	Ŀ				
	AE	4,115,736	9/19/1978	Tracy						
	AF	4,383,178	5/10/1983	Shibata et al.						
	AG	4,694,245	9/15/1987	Frommes	<u> </u>	igspace				
	AH	4,731,577	3/15/1988	Logan			Ŀ			<u> </u>
	Al	4,755,746	7/5/1988	Mallory et al.			<u> </u>	1		
	AJ	4,757,255	7/12/1988	Margozzi	<u> </u>					•
	AK	4,758,785	7/19/1988	Rath						
	AL	4,771,234	9/13/1988	Cook et al.						
	AM	4,845,426	7/4/1989	Nolan et al.						· · · · · · · · · · · · · · · · · · ·
	AN	4,856,904	8/15/1989	Akagawa			·			
	AO	4,884,026	11/28/1989	Hayakawa et al.						
	AP	5,077,523	12/31/1991	Blanz						
	ĄQ	5,084,671	1/28/1992	Miyata et al.	<u> </u>					<u> </u>
	AR	5,220,277	6/15/1993	Reitinger	·				•	
	AS	5,266,889	11/30/1993	Harwood et al.						
	АТ	5,345,170	9/6/1994	Schwindt et al.						
	ΑU	5,457,398	10/10/1995	Schwindt et al.						
	AV	5,963,027	10/5/1999	Peters						
	AW	6,002,263	12/14/1999	Peters et al.				_		
	AX	6,252,392	06/26/2001	Peters						
	AY	6,288,557	09/11/2001	Peters et al.						
	AZ	6,362,636	03/26/2002	Peters et al.	$\perp J$				•	·
an.	ВА	6,489,789	12/03/2002	Peters et al.						·
			FOREIGN P	ATENT DOCUMENTS			1			
		DOCUMENT NUMBER	DATE	COUNTRY	CL	ASS	SUF	BCLASS	TRANS	LATION
	ļ								YES	NO
σv	BB.	1-209380	8/1989	Japan	 -	<u> </u>				
	BC	2-220453	9/1990	Japan	 -	<u> </u>		_	 -	
	BD	201205	12/1986	European Patent Office	 					
	BE	3114466	3/1982	Germany	+					
	BF	2-022837	1/1990	Japan	↓_ =	=	<u> </u>			
T2	BG	4-000732	1/1992	Japan	<u></u>		<u></u> :		L	

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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT					
(Use several sheets if necessary)	FILING DATE July 8, 2003	GROUP			

		July 8, 2003						
	ŧ	OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
. ,	вн	"Model TPO3000 Series Thermochuck® Systems," four-page product note, Temptronic Corporation, Newton, MA						
ON		(May 1992 or earlier)						
Ī	ві	"Application Note 1 Controlled Environment Enclosure," two-page application note, "Temptronic Corporation, Newton,						
		MA (May 1992 or earlier)						
	BJ	"Cross Section Signatone S-1240," one-page sketch prepared by Signatone counsel, Signatone, San Jose, CA (February						
	<u> </u>	1988 or earlier per Signatone)						
	вк	"S-1240," two-page product note, Signatone, San Jose, CA (February 1988 or earlier per Signatone counsel)						
	BL	Y. Yamamoto, "A Compact Self-Shielding Prober," IEEE Trans., Inst. and Meas., Vol. 38, pp 1088-1093, 1989						
	ВМ	Temptronic's "Guarded" Chuck, one-page note describing guarding system of Temptronic Corporation of Newton, MA,						
		dated 11/15/89						
	BN	Beck & Tomann, "Chip Tester," IBM Technical Disclosure Bulletin, p. 4819 (January 1985)						
	во	Article by William Knauer entitled "Fixturing for Low-Current/Low Voltage Parametric Testing," appearing in						
		Evaluation Engineering, (1990) pp. 150-153						
·	BP	Hewlett-Packard, "Application Note 356-HP 4142B Modular DC Source/Monitor Practical Applications,"						
		(Nov. 1987) pp. 1-4						
	ВQ	Hewlett-Packard, H-P Model 4284A Precision LCR Meter, Operation Manual (December 1991) pp. 2-1, 6-9 and 6-15						
	BR	Cascade Microtech, "Advanced On-Wafer Device Characterization Using the Summit 10500, (December 1992)						
	BS	Micromanipulator Company, Inc., "Test Station Accessories," 1983. (month unavailable)						
	<u> </u>							
	ВТ	Micromanipulator Company, Inc., "Model 8000 Test Station," 1986. (month unavailable)						
	,							
	BU	Micromanipulator Company, Inc., "Model 8000 Test Station," 1988. (month unavailable)						
	BV	Micromanipulator Company, Inc., "Probing Stations and Accessories," 1995, pp. 1-12.						
	вw	Photograph of Micromanipulator Probe Station, 1994.						
	<u> </u>							
- /	вх	Applebay, Harry F., Deposition transcript (pp. 61-67) with Exhibits 581 A, B, C describing Flexion AP-1 probe station						
ON		sold in 1987.						
EXAMIN	IER -	DATE CONSIDERED						

EXAMINER DATE CONSIDERED 5/11/04

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.